

TOSHIBA Multi Chip Discrete Device

# HN7G01FU

Power Management Switch Application Driver Circuit Application Interface Circuit Application

Q1 (transistor): 2SA1955 equivalent
Q2 (MOS-FET): 2SK1830 equivalent

# Q1 (transistor) Absolute Maximum Ratings (Ta = 25°C)

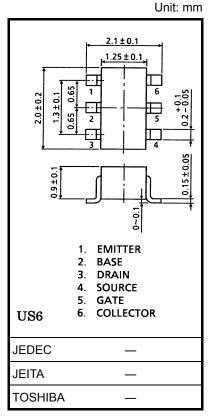
Characteristics	Symbol	Rating	Unit
Collector-base voltage	V <sub>CBO</sub>	-15	V
Collector-emitter voltage	V <sub>CEO</sub>	-12	V
Emitter-base voltage	V <sub>EBO</sub>	-5	V
Collector current	IC	-400	mA
Base current	ΙΒ	-50	mA

### Q2 (MOS-FET) Absolute Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Drain-source voltage	$V_{DS}$	20	V
Gate-source voltage	V <sub>GSS</sub>	10	٧
Drain current	ΙD	50	mA

### Q1, Q2 Common Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Power dissipation	P <sub>C</sub> (Note 1)	200	mW
Junction temperature	Tj	125	°C
Storage temperature range	T <sub>stg</sub>	-55~150	°C



Weight: 6.8 mg (typ.)

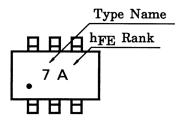
Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

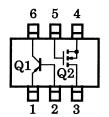
Note 1: Total rating

### Marking

Note:



# Pin Assignment (top view)



# Q1 (transistor) Electrical Characteristics (Ta = 25°C)

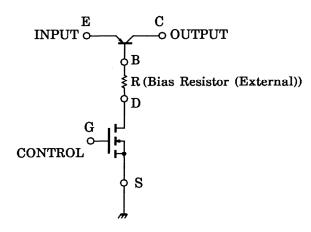
\\\\\	v.DataSheet4U.com Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
	Collector cut-off current	I <sub>CBO</sub>	$V_{CB} = -15 \text{ V}, I_E = 0$	_	_	-0.1	μА
	Emitter cut-off current	I <sub>EBO</sub>	$V_{EB} = -5 \text{ V}, I_C = 0$			-0.1	mA
	DC current gain	h <sub>FE</sub> (Note 2)	V <sub>CE</sub> = -2 V, I <sub>C</sub> = -10 mA	300	l	1000	
	Collector-emitter saturation voltage	V <sub>CE</sub> (sat) (1)	$I_C = -10$ mA, $I_B = -0.5$ mA		-15	-30	mV
	Concetor-critical saturation voltage	V <sub>CE</sub> (sat) (2)	$I_C = -200 \text{ mA}, I_B = -10 \text{ mA}$		-110	-250	IIIV
	Base-emitter saturation voltage	V <sub>BE</sub> (sat)	$I_C = -200 \text{ mA}, I_B = -10 \text{ mA}$		-0.87	-1.2	٧

Note 2: hFE classification A: 300~600, B: 500~1000

# Q2 (MOS-FET) Electrical Characteristics (Ta = 25°C)

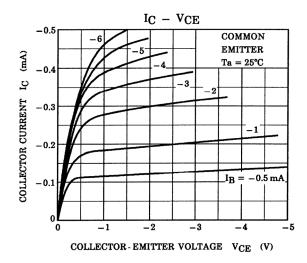
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current	I <sub>GSS</sub>	$V_{GS} = 10 \text{ V}, V_{DS} = 0$	_	_	1	μА
Drain-source breakdown voltage	V (BR) DSS	$I_D = 100 \ \mu A, \ V_{GS} = 0$	20	_	_	V
Drain current	I <sub>DSS</sub>	$V_{DS} = 20 \text{ V}, V_{GS} = 0$			1	μΑ
Gate threshold voltage	$V_{th}$	$V_{DS} = 3 \text{ V}, I_D = 0.1 \text{ mA}$	0.5	_	1.5	V
Forward transfer admittance	Y <sub>fs</sub>	$V_{DS} = 3 \text{ V}, I_{D} = 10 \text{ mA}$	20	_	_	mS
Drain-source ON resistance	R <sub>DS (ON)</sub>	$I_D = 10 \text{ mA}, V_{GS} = 2.5 \text{ V}$	_	20	40	Ω

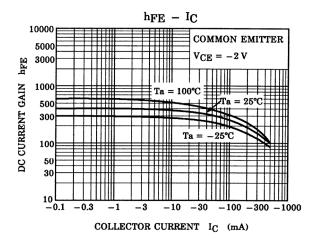
# **Application Example (power management switch)**

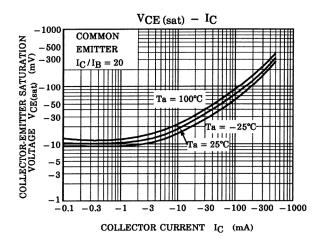


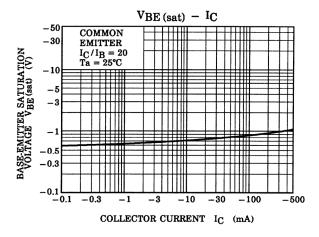
#### **Transistor**

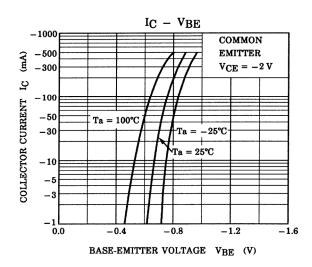
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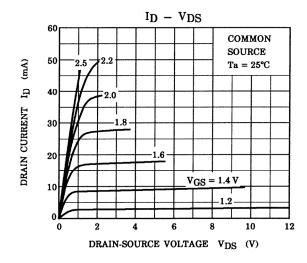


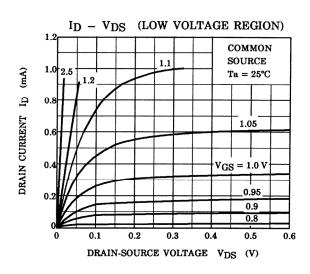


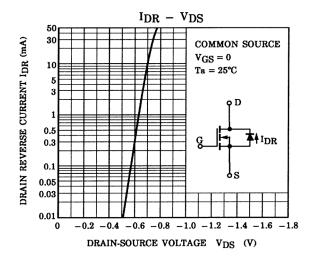


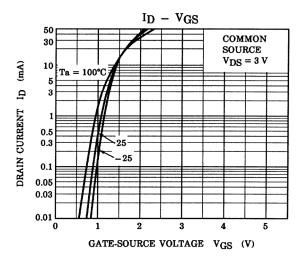
#### **MOS-FET**

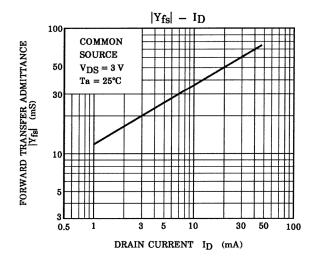
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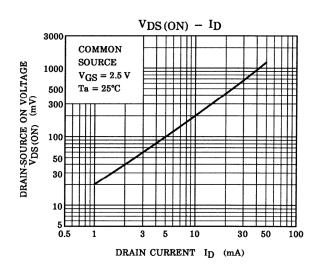












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